



**International
Standard**

ISO/IEC 20059

**Information technology —
Methodologies to evaluate the
resistance of biometric systems to
morphing attacks**

*Technologies de l'information — Méthodologies pour l'évaluation
de la résistance des systèmes biométriques aux attaques par
morphing*

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This document was prepared by Joint Technical Committee ISO/IEC JTC 1, *Information technology*, Subcommittee SC 37, *Biometrics*.

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